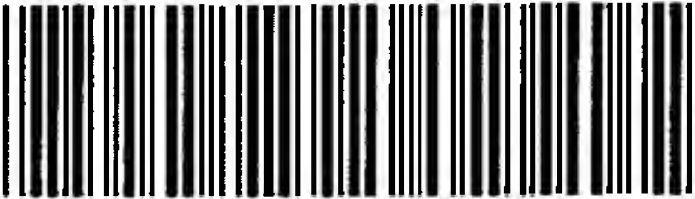


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/783,216	TUAN ET AL.	
	Examiner	Art Unit	
	Nelson Lam	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	4	2/27/2006	NL
716	2	2/27/2006	NL
716	3	2/27/2006	NL
716	6	2/27/2006	NL
716	16	2/27/2006	NL
365	200	2/27/2006	NL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	2/27/2006	NL
US-PGPUB; USPAT; JPO; DERWENT; IBM_TDB	2/27/2006	NL